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| Notice of References Cited | Application/Control No. 10/780,504 | Applicant(s)/Patent Under Reexamination JONES ET AL. | |
| | Examiner R. Alexander Smith | Art Unit 2859 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| | A | US-6,146,006 A | 11-2000 | Cross, David M. | 362/555 |
| | B | US-6,075,872 A | 06-2000 | McGuire, Kevin P. | 382/100 |
| | C | US-6,035,567 A | 03-2000 | Cameron, Robert W. | 40/607.04 |
| | D | US-5,911,612 A | 06-1999 | Steger, Ralph E. | 441/118 |
| | E | US-5,831,522 A | 11-1998 | Weed et al. | 340/473 |
| | F | US-5,774,202 A | 06-1998 | Abraham et al. | 351/177 |
| | G | US-5,760,531 A | 06-1998 | Pederson, John C. | 313/25 |
| | H | US-5,588,156 A | 12-1996 | Panton, Jr., George S. | 2/243.1 |
| | I | US-5,337,047 A | 08-1994 | Myers, Michael V. | 340/945 |
| | J | US-5,294,924 A | 03-1994 | Dydzik, Dmytro | 340/908.1 |
| | K | US-5,072,456 A | 12-1991 | Elin, Lewis R. | 2/94 |
| | L | US-5,050,924 A | 09-1991 | Hansen, George G. | 296/100.15 |
| | M | US-3,863,207 A | 01-1975 | Galella, Ottavio | 340/907 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|----------------|---------------|----------------|
| | N | JP 2001014591 A | 01-2001 | Japan | KUBO et al. | G08G 01/095 |
| | O | WO 9924671 A | 05-1999 | WIPO | BOYD | E01F 09/012 |
| | P | GB 2274295 A | 07-1994 | United Kingdom | HOUGHTON, H V | E01F 09/00 |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/780,504 | Applicant(s)/Patent Under Reexamination JONES ET AL. | |
| | Examiner R. Alexander Smith | Art Unit 2859 | Page 2 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| | A | US-3,723,725 A | 03-1973 | Jaeger, Robert O. | 362/35 |
| | B | US-2,280,817 A | 04-1942 | FREEMAN ARTHUR C | 40/545 |
| | C | US-6,517,214 B1 | 02-2003 | Mitchell et al. | 362/108 |
| | D | US-6,388,194 B1 | 05-2002 | Ryeczek, John J. | 174/112 |
| | E | US-6,203,181 B1 | 03-2001 | Gross, Leon S. | 362/486 |
| | F | US-6,148,442 A | 11-2000 | Porter, A. Lee | 2/69 |
| | G | US-5,564,128 A | 10-1996 | Richardson, Patrick J. | 2/422 |
| | H | US-4,839,647 A | 06-1989 | Patterson, R. Gordon | 340/907 |
| | I | US-3,983,532 A | 09-1976 | Hayes, Royce | 340/907 |
| | J | US-3,875,561 A | 04-1975 | Scarpino et al. | 340/472 |
| | K | US-3,624,686 A | 11-1971 | Beals, Jean A. | 434/98 |
| | L | US-3,515,492 A | 06-1970 | BUTTERFIELD JAMES F | 356/256 |
| | M | US-2,618,866 A | 11-1952 | ADAMS CLYDE S | 434/328 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.